

Features

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low RDS(ON)

Product Summary



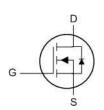
BVDSS	RDSON	ID
100V	12m Ω	50A

Applications

- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

PDFN5060-8L Pin Configuration





Absolute Maximum Ratings (T_A = 25°C, unless otherwise noted)

Parameter		Symbol	Value	Unit
Drain-Source Voltage		V _{DS}	100	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain Current	T _C =25°C	I _D	50	A
Continuous Drain Current	T _C =100°C		29	
Pulsed Drain Current ¹		I _{DM}	184	А
Single Pulse Avalanche Energy ²		EAS	80	mJ
Total Power Dissipation	T _C =25°C	P _D	71.4	W
Operating Junction and Storage Temperature Range		ТЈ, Тѕтс	-55 to 150	°C

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance from Junction-to-Ambient ³	Reja	52	°C/W
Thermal Resistance from Junction-to-Lead	Rejc	1.75	°C/W



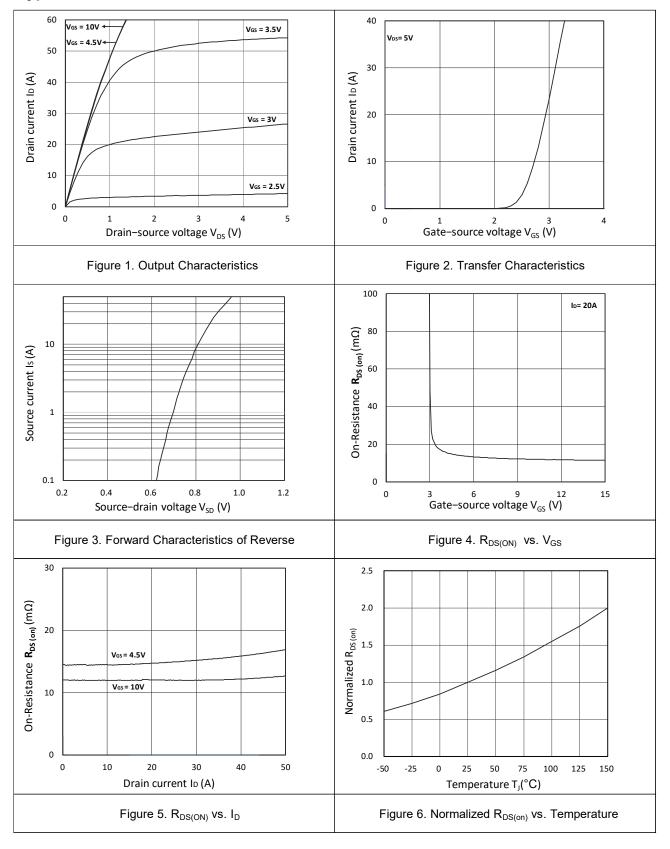
Electrical Characteristics (T_J = 25°C, unless otherwise noted)

Static Characteristics Drain-Source Breakdown Voltage V(BR)DSS V _{GS} = 0V, I _D = 250μA 100 - Gate-Body Leakage Current I _{GSS} V _{DS} = 0V, V _{GS} = ±20V - - Zero Gate Voltage Drain Current T _J =25°C T _J =100°C I _{DSS} V _{DS} = 100V, V _{GS} = 0V - - Gate-Threshold Voltage V _{GS} (th) V _{DS} = V _{GS} , I _D = 250μA 1 1.7 Drain-Source on-Resistance ⁴ R _{DS} (on) V _{GS} = 10V, I _D = 20A - 12 Forward Transconductance ⁴ gfs V _{DS} = 10V, I _D = 20A - 54 Dynamic Characteristics ⁵ Input Capacitance C _{Iss} V _{DS} = 50V, V _{GS} = 0V, f = 10Hz - 1208 Output Capacitance C _{Oss} V _{DS} = 50V, V _{GS} = 0V, f = 10Hz - 144 Reverse Transfer Capacitance R _G f = 1MHz - 1.8 Switching Characteristics ⁵ Total Gate Charge Q _g V _{GS} = 10V, V _{DS} = 50V, I _D = 20V, I _D = 20A - 2.2.7 Gate-Source Charge Q _g V _{GS} = 10V, V _{DS} = 50V, I _D = 2	- ±100 1 100 2.5 17 20	V nA μA V mΩ
	1 100 2.5 17	nA - μA - V - mΩ
Zero Gate Voltage Drain Current T _J =25°C T _J =100°C Ibss V _{DS} = 100V, V _{GS} = 0V -	1 100 2.5 17	- μA V - mΩ
Lips VDS = 100V, VGS = 0V Current Lips VDS = 100V, VGS = 0V Current Current TJ = 100°C Current TJ = 100°C Current TJ = 100°C Current Current TJ = 100°C Current C	100 2.5 17	V - mΩ
Current T _J =100°C V _{DS} = 100V, V _{GS} = 0V - 12 - - - 14.5 - - - - 54 - - 54 - - 54 - - 54 - - 54 - - 54 - - - 54 - <	2.5	V - mΩ
	17	mΩ
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		
	20	
Dynamic Characteristics⁵ Ciss VDS = 50V, VGS = 0V, F = 1MHz - 1208 Output Capacitance Coss F = 1MHz - 144 Reverse Transfer Capacitance Crss - 11.3 Gate Resistance RG f = 1MHz - 1.8 Switching Characteristics⁵ Total Gate Charge Qg VGS = 10V, VDS = 50V, DD = 50V, DD = 20A - 3	-	S
Input Capacitance	T	
Output Capacitance Coss VDS = 50V, VGS = 0V, f = 1MHz - 144 Reverse Transfer Capacitance Crss - 11.3 Gate Resistance RG f = 1MHz - 1.8 Switching Characteristics ⁵ - 22.7 Total Gate Charge Qg VGS = 10V, VDS = 50V, ID = 20A - 3		
	-	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	-	pF
Switching Characteristics ⁵ Total Gate Charge \mathbf{Q}_g - 22.7 Gate-Source Charge \mathbf{Q}_{gs} $V_{GS} = 10V, V_{DS} = 50V, I_{D} = 20A$ - 3	-	
Total Gate Charge Q_g $V_{GS} = 10V, V_{DS} = 50V,$ $I_{D} = 20A$ $-$ 3	-	Ω
Gate-Source Charge Q_{gs} $V_{GS} = 10V, V_{DS} = 50V, I_{D} = 20A$ - 3		
Gate-Source Charge I _D = 20A - 3	-	nC
Cote Drain Charac	-	
Gate-Drain Charge Q _{gd} - 5	-	
Turn-on Delay Time td(on) - 9.2	-	ns
Rise Time t_r $V_{GS} = 10V$, $V_{DD} = 50V$, $-$ 3.6	-	
Turn-off Delay Time $t_{d(off)}$ $R_G = 3\Omega$, $I_D = 20A$ - 25.6	-	
Fall Time t _f - 4.4	-	
Body Diode Reverse Recovery Time t _{rr} - 30	-	ns
Body Diode Reverse Recovery Charge \mathbf{Q}_{rr} I _F = 20A, dI/dt = 100A/ μ s - 42	-	nC
Drain-Source Body Diode Characteristics	_1	
Diode Forward Voltage ⁴ V_{SD} $I_S = 20A, V_{GS} = 0V$	1.2	V
Continuous Source Current T _C =25°C Is	50	А

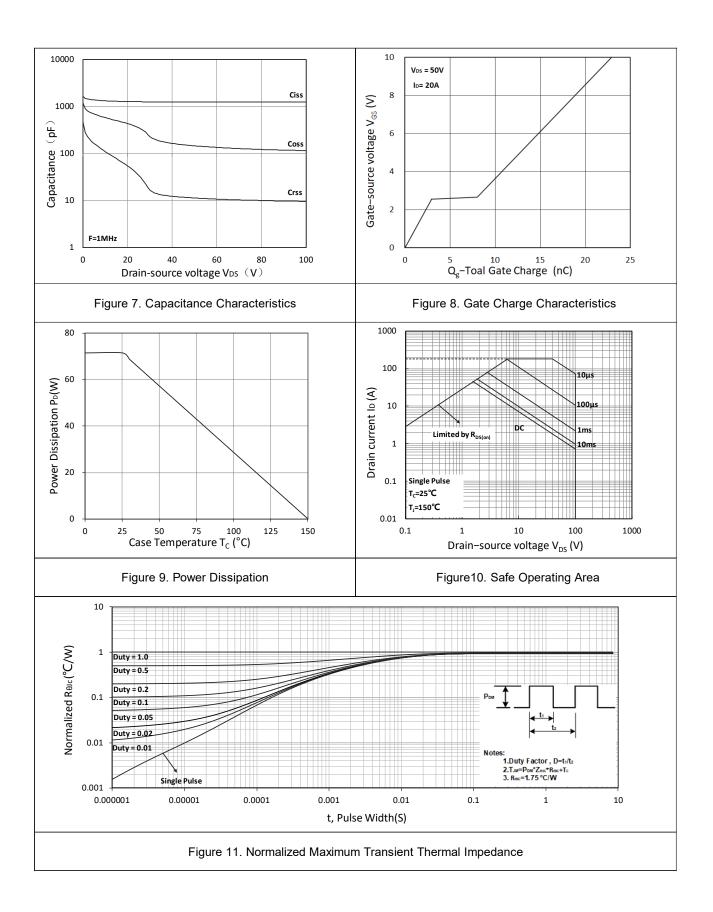
- 1. Repetitive rating, pulse width limited by junction temperature $T_{\text{J}(\text{MAX})}\!\!=\!\!150^{\circ}\text{C}$
- 2. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =40A.
- 3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- 4. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 5. This value is guaranteed by design hence it is not included in the production test.



Typical Characteristics









Test Circuit

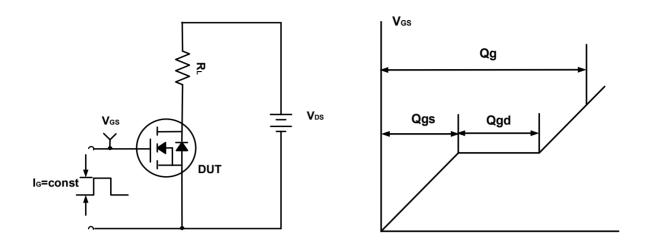


Figure A. Gate Charge Test Circuit & Waveforms

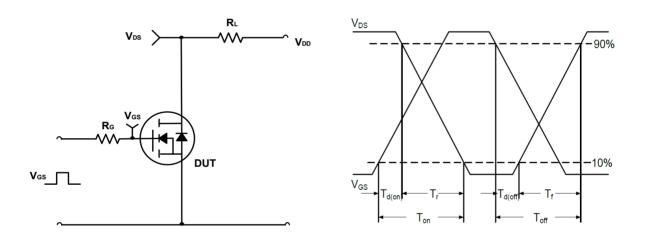


Figure B. Switching Test Circuit & Waveforms

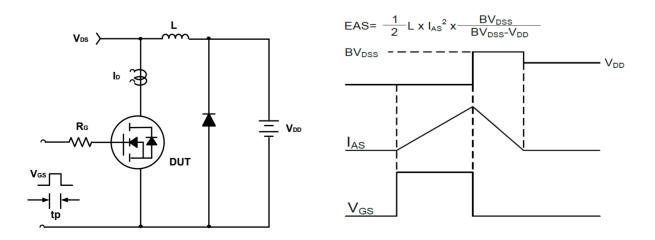
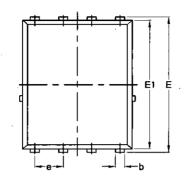
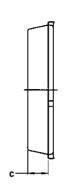


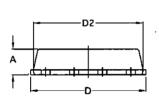
Figure C. Unclamped Inductive Switching Circuit & Waveforms

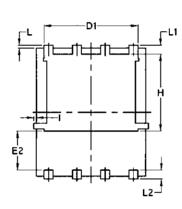


Package Mechanical Data-PDFN5060-8L-Single









Symbol	Common	Common				
	mm	mm		Inch		
	Mim	Max	Min	Max		
Α	1.03	1.17	0.0406	0.0461		
b	0.34	0.48	0.0134	0.0189		
С	0.824	0.0970	0.0324	0.082		
D	4.80	5.40	0.1890	0.2126		
D1	4.11	4.31	0.1618	0.1697		
D2	4.80	5.00	0.1890	0.1969		
E	5.95	6.15	0.2343	0.2421		
E1	5.65	5.85	0.2224	0.2303		
E2	1.60	/	0.0630	/		
е	1.27 BSC		0.05 BSC			
L	0.05	0.25	0.0020	0.0098		
L1	0.38	0.50	0.0150	0.0197		
L2	0.38	0.50	0.0150	0.0197		
Н	3.30	3.50	0.1299	0.1378		
1	/	0.18	/	0.0070		